## Nonstoichiometry as a hidden aspect of TbAl<sub>3</sub>(BO<sub>3</sub>)<sub>4</sub> optical properties

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Table S1. Summary data about the single crystal XRD data-collection parameters, structure refinement of crystals from batch II (Figure 1).

Chemical formula	TbAl <sub>3</sub> (BO <sub>3</sub> ) <sub>4</sub>			
Temperature (K)	220			
Cell setting	trigonal			
Space group	R32			
a (Å)	9.2986(2)			
$b(\dot{A})$	9.2986(2)			
<i>c</i> (Å)	7.2542(2)			
$\alpha(^{\circ})$	90			
β (°)	90			
$\gamma(^{\circ})$	120			
$V(Å^3)$	543.19(3)			
Ζ	3			
Calculated density, $D_x$ (g cm <sup>-3</sup> )	4.357			
Crystal size (mm)	$0.18 \times 0.09 \times 0.03$			
Crystal form	plate			
Data collection				
Diffractometer	Bruker D8 Venture diffractometer, Bruker PHOTON III area detector			
Radiation; $\lambda$	Mo <i>K</i> <sub>a</sub> ; 0.71073			
,	-14 < h < 14,			
Data range $\theta(^{\circ})$ ; $h, k, l$	-14 < k < 12,			
	-11 < l < 11			
No. of measured reflections	4817			
Total reflections $(N_2)$ / observed $(N_1)$	538			
Criterion for observed reflections	$I > 3\sigma(I)$			
$R_{\rm int}$ (%)	5.05			
Refinement				
$R_1, wR_1 \left[ I > 3\sigma(I) \right]$	0.0094			
$R_1, wR_1$ [all]	0.0219			
GooF (Goodness of fit)	1.1			



Figure S1. Rietveld plot of the sample from batch II (Figure 1).



at 1100 °C in Ar atmosphere.



Figure S3 XRD patterns of xTbAl<sub>3</sub>(BO<sub>3</sub>)<sub>4</sub>- (1-x)Al<sub>2</sub>O<sub>3</sub>+B<sub>2</sub>O<sub>3</sub> samples annealing at a) 800 °C and b) 1200 °C in Ar atmosphere



Figure S4. DSC curves of xTbBO<sub>3</sub>-(1-x)Al<sub>2</sub>O<sub>3</sub>·B<sub>2</sub>O<sub>3</sub> samples syntheses by a) SSS (1100°C) and b) SCS (1200°C).



Figure S5 The excitation (PLE) and emission (PL) spectra of the a) TbAl<sub>3</sub>(BO3)<sub>4</sub>-TbBO<sub>3</sub> 1100°C\_Ar and b) annealing at 1200 C after combusted method  $\lambda_{ex} = 375$ nm,  $\lambda_{em} = 541$  nm, T = 300 K

Table S2. Summary data about the powder XRD data-collection parameters, the Rietveld structure refinement of crystals from batch II (Figure 1).

	1
Empirical formula	$Tb_{1.12}Al_{2.88}(BO_3)_4$
Formula weight	490.89
Crystal system	trigonal
Space group	R32
a (Å)	9.2967(3)
b (Å)	9.2967(3)
c (Å)	7.2511(1)
α	90
β°	90
γ	120
Ζ	3
Volume (Å <sup>3</sup> )	542.74(3)
Diffractometer	TD 3700(Tongda, China)
Radiation type	CuKa
Wavelength (A°)	1.5418
Profile range (2teta)	10-120
Step size (12y)	0.02
Number of observation (N)	5499
Number of contributing reflections	113
Number of structure parameters (P1)	24
Number of profile parameters (P2)	10
RBragg (%)	8.44
Rp (%)	7.36
Rwp (%)	9.36
Rexp (%)	8.39
GOF	1.118

Table S3. The final atomic coordinates and equivalent isotropic displacement parameters in								
Tb <sub>1.12</sub> Al <sub>2.88</sub> (BO <sub>3</sub> ) <sub>4</sub> .								
Atom	x	у	z	осс	U_iso_or_equiv			
Tb1	0	0	0	1	0.0226(9)			
Tb2	0.5555(7)	0	0	0.040(6)	0.034(4)			
Al3	0.5555(7)	0	0	0.960(6)	0.034(4)			
B1	0	0	0,5	1	0.031(7)			
B2	0.429(7)	0	0,5	1	0.031(7)			
01	0.1416(12)	0.1416(12)	0,5	1	0.016(2)			
02	0.4423(12)	0.1420(11)	0.519 (2)	1	0.016(2)			
03	0.578(3)	0	0,5	1	0.016(2)			